

Measuring resistance of a high temperature superconducting sample using MFLI from Zurich Instruments and an Optistat™Dry from Oxford Instruments



Introduction

This application note describes an experiment to measure the resistance of High Temperature Superconductor (HTS) tape and determine the superconducting transition temperature, T_c . The measurements were carried out using Oxford Instruments' **Optistat**Dry cryogenic system with the demountable sample puck option, combined with a Zurich Instruments' MFLI (Medium Frequency Lock-In) amplifier. The experiment demonstrates the adaptability and controllability of the cryogenic platform as well as the ability of the **MFLI** to resolve small signals with excellent background noise rejection.

Experimental set-up

The **Optistat**Dry was set-up with the MFLI and a break-out box (see Figure 1). SuperPower 2G YBCO HTS tape, from Furukawa Electric was used as the sample. A 500 mm length of this tape was coiled in a non-inductive loop and mounted to an **Optistat**Dry sample puck using a custom made copper bracket (see Figure 2). The 12 mm wide tape had voltage taps applied 15 mm from each end, giving 470 mm between the voltage taps. Current supply terminals were added at each end of the tape to provide an excitation current through the tape. The sample puck included a CX 1050 SD Cernox™ sensor and a 50 Ω 25 W surface-mount heater. The room-temperature end-to-end resistance of the current loop (HTS sample plus wiring loom plus cabling) was 149.2 Ω measured at the break-out box terminals. The **Optistat**Dry heat exchanger also has a CX 1050 SD Cernox™ sensor and a heater. The system, under **Mercury**iTC control, allows for simultaneous sweeps of the heat exchanger and sample puck temperatures at precise user selected rates. To resolve the superconducting transition in the YBCO, temperature sweeps were conducted at 0.1 K/min, 0.05 K/min and 0.01 K/min over the transition region. The **MFLI** was used, both as a low-distortion function generator and as a lock-in amplifier to recover the small demodulated response. Its Scope capability also allowed monitoring of the input signal in real time.



Figure 1. Set-up of **MFLI** lock-in amplifier and **Optistat**™Dry Cryofree® cryostat



Figure 2. YBCO coil (marked with the arrow) mounted on the sample puck

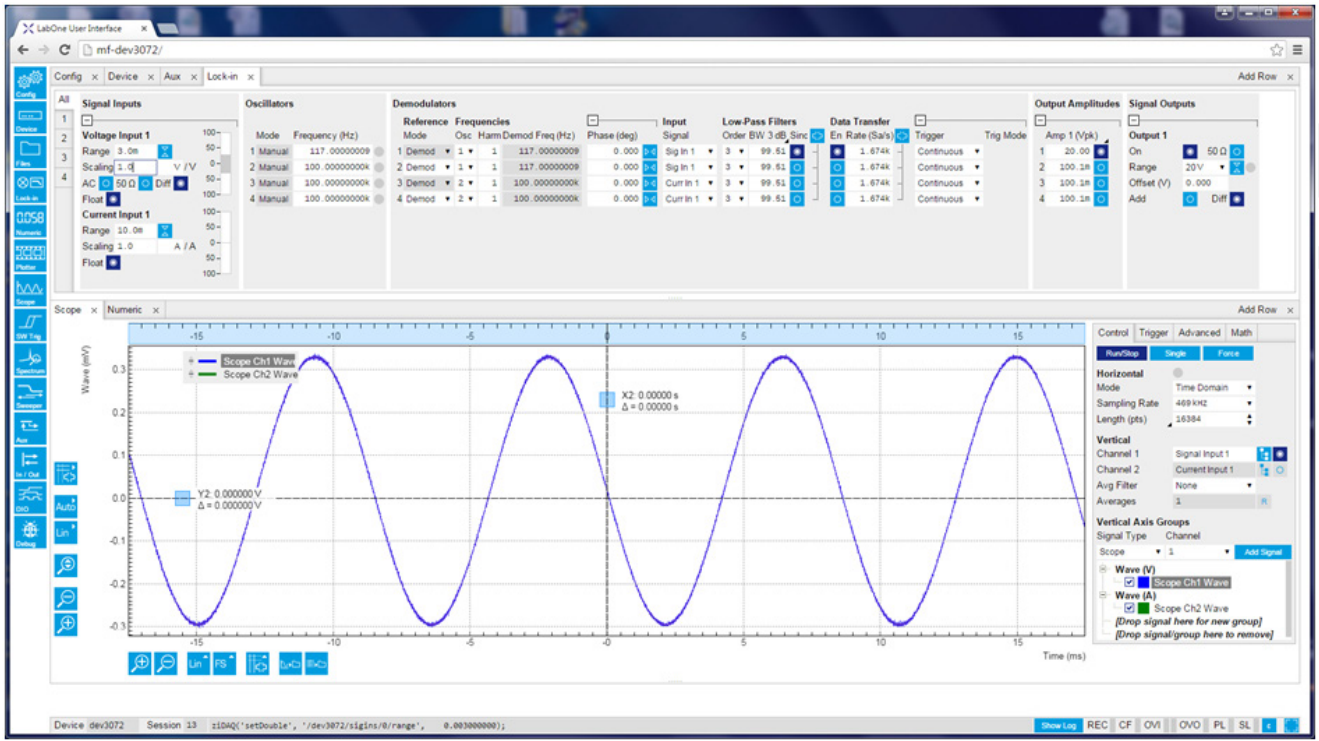


Figure 3. The **MFLI** LabOne interface from Zurich Instruments. The scope chart shows the signal across the YBCO at 100 K with a ± 20 V, 117 Hz excitation, peak-to-peak voltage of 0.62 mV.

Mercury settings

- Three temperature sensors:
(1st stage, heat exchanger, sample puck)
- Two control loops:
 - Sample puck sensor/heater:
PID 100, 0.1, 0
 - Heat exchanger sensor/heater:
PID 100, 0.2, 0
- Temperature sweeps:
 - 86 K to 92 K at 0.1 K/min
 - 89 K to 92 K at 0.05 K/min and 0.01 K/min

MFLI settings (see Figure 3)

- Excitation:
 - Profile Sinusoidal
 - Frequency 117 Hz
 - Amplitude ± 20 V
 - Configuration Differential
- Measurement:
 - Mode Scope wave / LIA
 - Configuration Differential
 - Input range 3 mV
 - Scaling factor 1
 - Sample rate 469 kHz
 - Transfer rate 1674 Sa/s
 - Data buffer 16384 samples
 - PC read rate 1 Sa/s



Experimental results

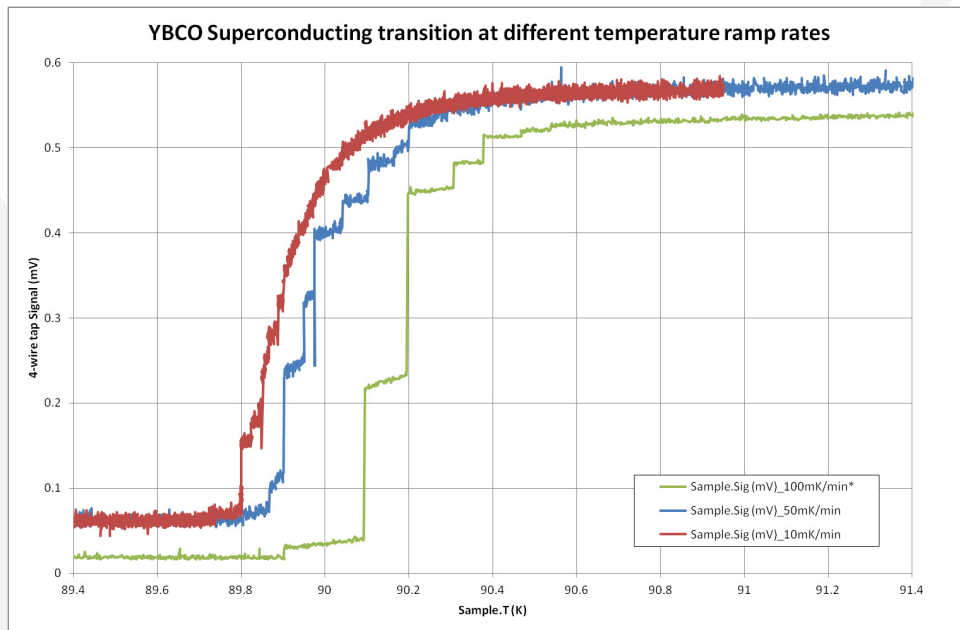


Figure 4. T_c data showing the propagation of the superconducting state through the YBCO material as the coiled tape sample is warmed at different heating rates. *Note: a smaller excitation voltage was applied for the 100 mK/min.

The puck loading system of the **OptistatDry** is optimised for small quantum device samples but can easily be adapted for larger items. The data in Figure 4 shows the superconducting transition (T_c) occurs over a temperature range because there is a temperature gradient across the relatively large coil of YBCO, which is approximately 40 mm in diameter. The faster temperature sweeps expose the granular nature of the YBCO material. The domains appear to change state in avalanche groups as the temperature of the YBCO loop rises. The transition can be controlled and resolved more uniformly using a slower temperature sweep, which is easily achieved with the precision and accuracy of the **MercuryITC** controller.

A 4-wire resistance measurement technique is not the ideal method for determining the T_c of a material. This measurement is an exercise to demonstrate the adaptability and measurement qualities of the **OptistatDry** system and the MFLI. The small signals which needed to be resolved in making these measurements would have been challenging for a DC resistivity technique. Using an AC-technique with the MFLI lock-in amplifier, makes these measurements achievable. Without taking excessive care with cabling, it was still possible to reach a noise base of around 12 μ V. The measurement frequency of 117 Hz was chosen to avoid higher frequency cross-talk from the cabling, as well as significant phase shift between the excitation and measurement signals and to minimise higher harmonic components. With the multi-demodulator MFLI input, harmonic distortion can be measured simultaneously (not shown here).

The break-out box (see Figure 1), as well as including electrostatic discharge protection, also included a precision in-line 5 m Ω resistor. From this, it was possible to use the same measurement technique to establish that the excitation current flowing through the YBCO sample was 104 mA, when the sample was at a temperature of 91 K. It showed a normal state resistance value of 5.48 m Ω for the YBCO tape and backing material. From the SuperPower datasheet for this tape batch, the actual width is 12.04 mm with a thickness of 216 microns. From this measurement of the resistance of the 470 mm length we can estimate the normal state resistivity of the tape (YBCO plus backing material) to be 3×10^{-8} Ω m.

Conclusion and outlook

The superconducting transition of YBCO could be clearly demonstrated at various heating rates. With such a cryogenic and instrumentation configuration, many differential measurements of various physical properties (resistivity, current, capacitance, etc.) can be performed over a wide range of temperatures and driving modulation. Phase information and multi-demodulator configuration, at higher harmonics or multiple frequencies can be acquired at the same time without any hardware modification, allowing for more flexibility in the design of such low-temperature experiments.

About the **OptistatDry Cryofree**[®] cryostat

The **OptistatDry** provides a temperature controlled sample in vacuum measurement environment within a **Cryofree** cryostat. The **OptistatDry** comprises a range of compact cryostats with optical access cooled by a closed cycle refrigerator. The system is capable of cooling samples to helium temperatures without the need for liquid cryogens. This provides significant benefits in terms of ease of use and running costs. The system enables optical and electrical measurements to be carried out on your samples, as shown in this application note.

About the **MFLI** lock-in amplifier

Zurich Instruments' **MFLI** uses the latest hardware and software technologies to bring the benefits of high performance digital signal processing to lock-in amplifiers at medium and low frequencies. The **MFLI** features a differential voltage input as well as a current input, a dual-phase demodulator and a high quality signal generator, covering a frequency range DC to 500 kHz or DC to 5 MHz. With its superior performance and outstanding tool-set, the **MFLI** defines a new standard for lock-in amplifiers.



OptistatDry Cryofree cryostat
from Oxford Instruments



MFLI lock-in amplifier
from Zurich Instruments

Contact us at:

Oxford Instruments NanoScience
nanoscience@oxinst.com
www.oxford-instruments.com

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